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Application/Control No.	Applicant(s)/Patent under Reexamination	
10/721,330	KIM ET AL.	
Examiner	Art Unit	
Michael A. Friedhofer	2832	

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Class	Subclass	Date	Examiner
200	293- 296,303, 307	2/28/2007	MAF
312	228,263	2/28/2007	MAF
312	265.6	2/28/2007	MAF
312	293.2	2/28/2007	MAF
312	293.1	2/28/2007	MAF
312	257.1	2/28/2007	MAF
361	729-731	2/28/2007	MAF
361	735	2/28/2007	MAF
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